

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/552,463	ISHII ET AL.
	Examiner	Art Unit
	L. E. Crane	1623

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
536	027.110	2/1/2008	LEC
536	028.530	2/1/2008	LEC